

2SB1148, 2SB1148A

Silicon PNP epitaxial planar type

For low-voltage switching

Complementary to 2SD1752 and 2SD1752A

■ Features

- Low collector-emitter saturation voltage $V_{CE(sat)}$
- High-speed switching
- I type package enabling direct soldering of the radiating fin to the printed circuit board, etc. of small electronic equipment

■ Absolute Maximum Ratings $T_C = 25^\circ\text{C}$

Parameter	Symbol	Rating	Unit	
Collector-base voltage (Emitter open)	2SB1148	V_{CBO}	-40	V
	2SB1148A		-50	
Collector-emitter voltage (Base open)	2SB1148	V_{CEO}	-20	V
	2SB1148A		-40	
Emitter-base voltage (Collector open)	V_{EBO}	-7	V	
Collector current	I_C	-10	A	
Peak collector current	I_{CP}	-20	A	
Collector power dissipation	P_C	15	W	
		$T_a = 25^\circ\text{C}$		1.3
Junction temperature	T_j	150	$^\circ\text{C}$	
Storage temperature	T_{stg}	-55 ~ +150	$^\circ\text{C}$	

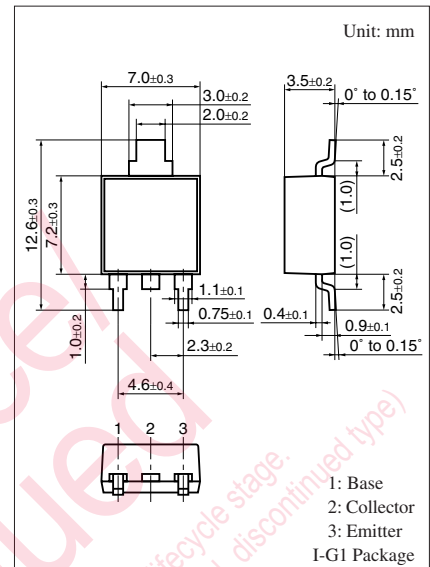
■ Electrical Characteristics $T_C = 25^\circ\text{C} \pm 3^\circ\text{C}$

Parameter	Symbol	Conditions	Min	Typ	Max	Unit	
Collector-emitter voltage (Base open)	2SB1148	$I_C = -10 \text{ mA}, I_B = 0$	-20			V	
	2SB1148A		-40				
Collector-base cutoff current (Emitter open)	2SB1148	$V_{CB} = -40 \text{ V}, I_E = 0$			-50	μA	
	2SB1148A	$V_{CB} = -50 \text{ V}, I_E = 0$			-50		
Emitter-base cutoff current (Collector open)	I_{EBO}	$V_{EB} = -5 \text{ V}, I_C = 0$			-50	μA	
Forward current transfer ratio	h_{FE1}	$V_{CE} = -2 \text{ V}, I_C = -0.1 \text{ A}$	45			—	
	h_{FE2}^*	$V_{CE} = -2 \text{ V}, I_C = -1 \text{ A}$	90		260		
Collector-emitter saturation voltage	$V_{CE(sat)}$	$I_C = -10 \text{ A}, I_B = -0.33 \text{ A}$			-0.6	V	
Base-emitter saturation voltage	$V_{BE(sat)}$	$I_C = -10 \text{ A}, I_B = -0.33 \text{ A}$			-1.5	V	
Transition frequency	f_T	$V_{CE} = -10 \text{ V}, I_C = -0.5 \text{ A}, f = 10 \text{ MHz}$		100		MHz	
Collector output capacitance (Common base, input open circuited)	C_{ob}	$V_{CB} = -10 \text{ V}, I_E = 0, f = 1 \text{ MHz}$		400		pF	
Turn-on time	t_{on}	$I_C = -3 \text{ A}, I_{B1} = -0.1 \text{ A}, I_{B2} = 0.1 \text{ A}$ $V_{CC} = -20 \text{ V}$		0.1		μs	
Storage time	t_{stg}				0.5		μs
Fall time	t_f				0.1		μs

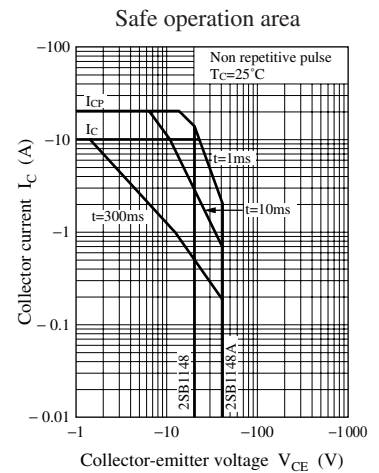
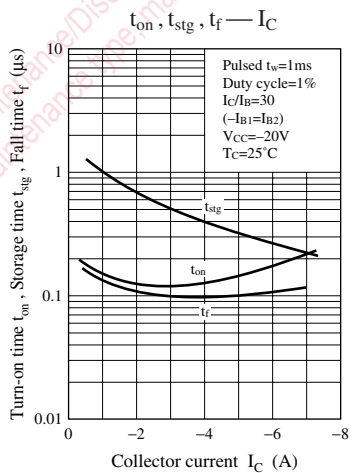
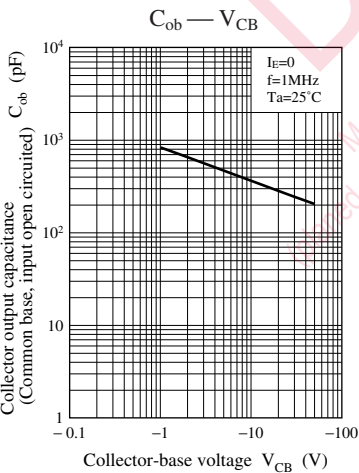
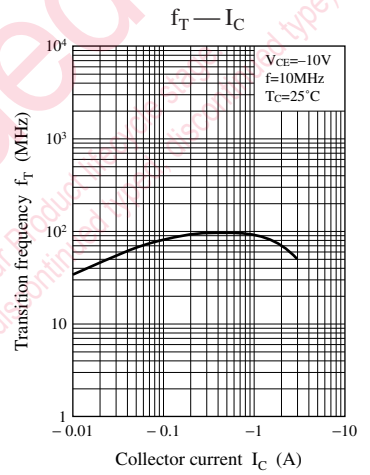
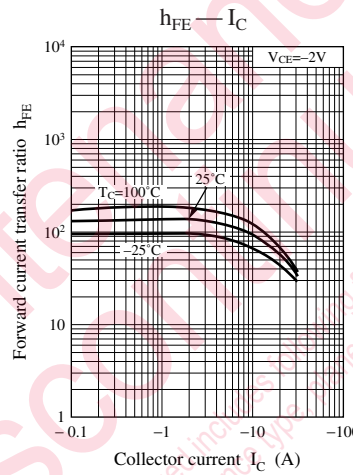
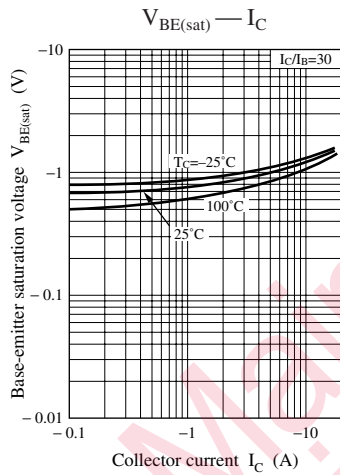
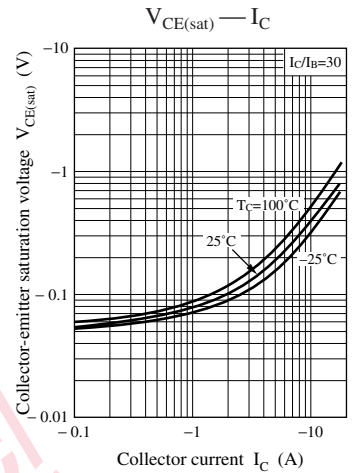
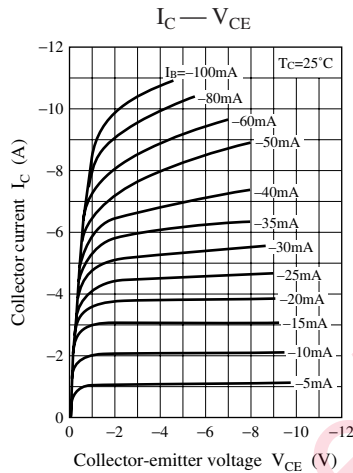
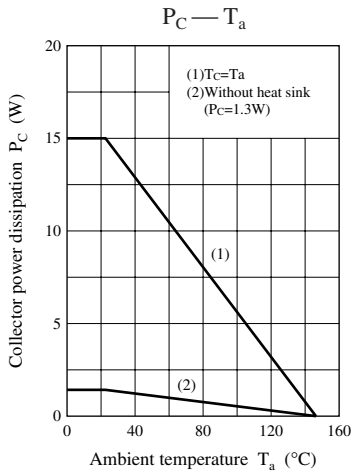
Note) 1. Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 measuring methods for transistors.

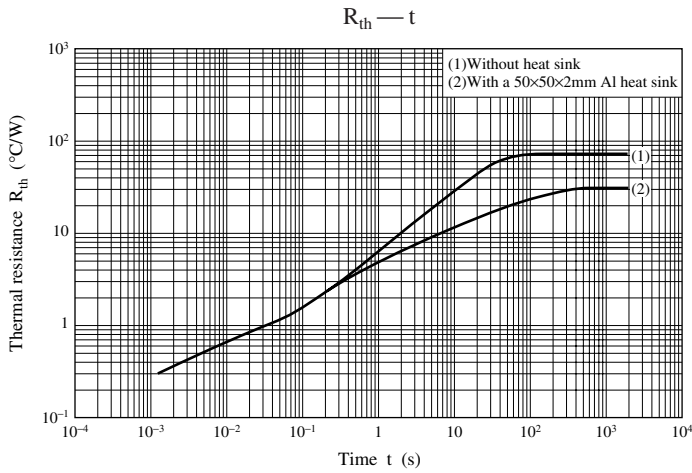
2. *: Rank classification

Rank	Q	P
h_{FE2}	90 to 180	130 to 260



Note) Self-supported type package is also prepared.





Maintenance/Discontinued

Maintenance/Discontinued includes following four Product lifecycle stage.
(planned maintenance type, maintenance type, planned discontinued type, discontinued type)

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